WHAT IS CLAIMED IS:

- 1. A spin coating apparatus for coating photoresist, comprising:
- a spin chuck comprising a mount part, for mounting a wafer thereon, and an extended projection part for facilitating formation of an edge-bead thereon; and
- a nozzle for depositing photoresist onto a wafer mounted on the mount part of the spin chuck.
- 2. The spin coating apparatus according to claim 1, wherein the extended projection part of the spin chuck has a height lower than that of the wafer mounted on the mount part.
- 3. The spin coating apparatus according to claim 1, wherein the extended projection part of the spin chuck has a height equal to that of the wafer mounted on the mount part.
- 4. The spin coating apparatus according to claim 1, wherein the extended projection part of the spin chuck surrounds a circumference of the wafer while being in contact with the circumference of the wafer mounted on the mount part.
- 5. The spin coating apparatus according to claim 1, wherein the spin chuck further comprises a separation part for separating the wafer from the spin chuck.
- 6. The spin coating apparatus according to claim 1, which further comprises a gas exhaust part disposed so that gas is exhausted from an edge of the wafer in a turning direction of the wafer and a centrifugal direction upon rotation of the wafer.

- 7. A spin coating apparatus for coating photoresist, comprising:
- a spin chuck for rotating a wafer;
- a nozzle part for depositing photoresist onto the wafer mounted on the spin chuck; and
- a gas exhaust part disposed so that gas is exhausted from an edge of the wafer in a turning direction of the wafer and a centrifugal direction upon rotation of the wafer.
- 8. A spin chuck for a spin coating apparatus that coats photoresist onto a wafer, said spin chuck comprising:
 - a mount part adapted to mount a wafer thereon; and

an extended projection part, extending from said mount part, which has a height of less than or equal to a height of a wafer mounted on said mount part.